DATA SHEET



MOS FIELD EFFECT TRANSISTOR μ PA2792GR

SWITCHING N- AND P-CHANNEL POWER MOS FET

DESCRIPTION

The μ PA2792GR is N- and P-channel MOS Field Effect Transistors designed for Motor Drive application.

FEATURES

- Low on-state resistance
- N-channel $R_{DS(on)1}$ = 12.5 m Ω MAX. (V_{GS} = 10 V, I_D = 5 A) $R_{DS(on)2}$ = 21 m Ω MAX. (V_{GS} = 4.5 V, I_D = 5 A)
- Low input capacitance

N-channel C_{iss} = 2200 pF TYP.

- P-channel Ciss = 2200 pF TYP.
- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

Å<u>ĦĦ</u>Ħ N-channel 1 Source 1 2 : Gate 1 7, 8: Drain 1 P-channel 3 : Source 2 4 : Gate 2 5, 6: Drain 2 О Ħ Ħ Ħ 6.0 ±0.3 4.4 5.37 MAX 0.8 4 .8 MAX. ġ, ŝ C 0.5 ±0.2 0.05 MIN □ 0.10 1.27 0.78 MAX 0.40 +0.10 0.12 0

PACKAGE DRAWING (Unit: mm)

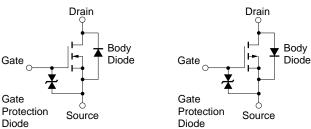
ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
μPA2792GR-E1-AZ ^{Note}			_		
//PA2792GR-F2-AZ Note	Sn-Bi	Tape 2500 p/reel	Power SOP8		

Note Pb-free (This product does not contain Pb in external electrode).

EQUIVALENT CIRCUITS

N-channel Drain P-channel



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT	
Drain to Source Voltage (Vos = 0 V)	VDSS	30 –30		V	
Gate to Source Voltage (V _{DS} = 0 V)	Vgss	±20	∓20	V	
Drain Current (DC)	ID(DC)	±10	∓10	А	
Drain Current (pulse) Note1	D(pulse)	±40 ∓40		А	
Total Power Dissipation (1 unit) Note2	P _{T1}	1.7		W	
Total Power Dissipation (2 units) Note2	P _{T2}	2	W		
Channel Temperature	Tch	150		°C	
Storage Temperature	Tstg	-55 to +150		٥C	
Single Avalanche Current Note3	las	10	-10	А	
Single Avalanche Energy Note3	Eas		mJ		

ABSOLUTE MAXIMUM RATINGS (TA = 25°C. All terminals are connected.)

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on ceramic substrate of 2000 $\text{mm}^2 \times 1.6 \text{ mm}$

3. Starting Tch = 25°C, VDD = 15 V, RG = 25 Ω , L = 100 μ H, VGS = 20 \rightarrow 0 V

ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)

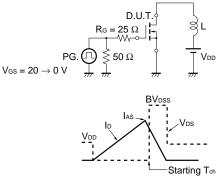
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V			10	μA
Gate Leakage Current	lgss	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = 10 V, I _D = 5 A	5	10		S
Drain to Source On-state Resistance ^{Note}	RDS(on)1	V _{GS} = 10 V, I _D = 5 A		10	12.5	mΩ
	RDS(on)2	V _{GS} = 4.5 V, I _D = 5 A		14.5	21	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V,		2200		pF
Output Capacitance	Coss	V _{GS} = 0 V,		380		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		250		pF
Turn-on Delay Time	t d(on)	V _{DD} = 15 V, I _D = 5 A,		9.6		ns
Rise Time	tr	V _{GS} = 10 V,		21		ns
Turn-off Delay Time	td(off)	R _G = 0 Ω		52		ns
Fall Time	tr			12		ns
Total Gate Charge	QG	I _D = 10 A,		42		nC
Gate to Source Charge	Q _{GS}	V _{DD} = 24 V,		6.2		nC
Gate to Drain Charge	Qgd	V _{GS} = 10 V		13		nC
Body Diode Forward Voltage Note	VF(S-D)	IF = 10 A, V _{GS} = 0 V		0.83	1.5	V
Reverse Recovery Time	trr	IF = 10 A, VGS = 0 V,		30		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		22		nC

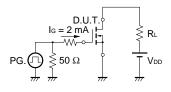
Note Pulsed

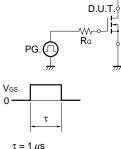
TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME

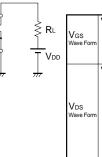


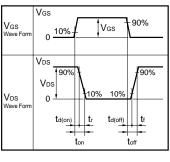
TEST CIRCUIT 3 GATE CHARGE





 $\tau = 1 \,\mu s$ Duty Cycle $\leq 1\%$





NEC

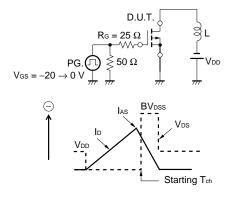
P-channel

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -30 V, V _{GS} = 0 V			-10	μA
Gate Leakage Current	Igss	V _{GS} = ∓20 V, V _{DS} = 0 V			∓10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.0	-1.7	-2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = -10 V, I _D = -5 A	6	12.9		S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = -10 V, I _D = -5 A		14	18	mΩ
	RDS(on)2	V_{GS} = -4.5 V, I _D = -5 A		17.5	26	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V,		2200		pF
Output Capacitance	Coss	V _{GS} = 0 V,		510		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		410		pF
Turn-on Delay Time	td(on)	$V_{DD} = -15 \text{ V}, \text{ Id} = -5 \text{ A},$		12		ns
Rise Time	tr	V _{GS} = -10 V,		19		ns
Turn-off Delay Time	td(off)	R _G = 0 Ω		130		ns
Fall Time	tr			36		ns
Total Gate Charge	QG	I _D = −10 A,		47		nC
Gate to Source Charge	Q _{GS}	$V_{DD} = -24 V,$		5.2		nC
Gate to Drain Charge	QGD	V _{GS} = -10 V		15		nC
Body Diode Forward Voltage Note	VF(S-D)	IF = 10 A, VGS = 0 V		0.87	1.5	V
Reverse Recovery Time	trr	IF = -10 A, VGS = 0 V,		57		ns
Reverse Recovery Charge	Qrr	di/dt = -50 A/ <i>µ</i> s		41		nC

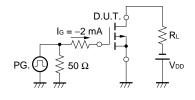
Note Pulsed

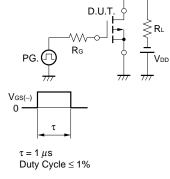
TEST CIRCUIT 1 AVALANCHE CAPABILITY

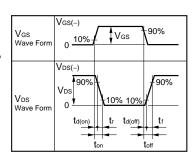
TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

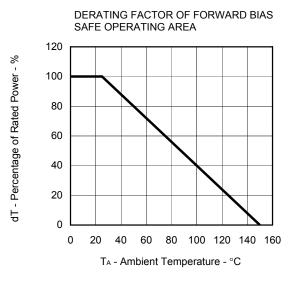




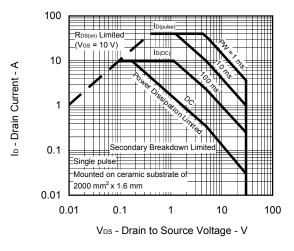


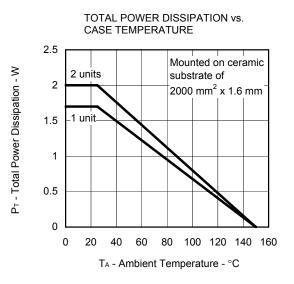
TYPICAL CHARACTERISTICS (TA = 25°C)

(1) N-channel

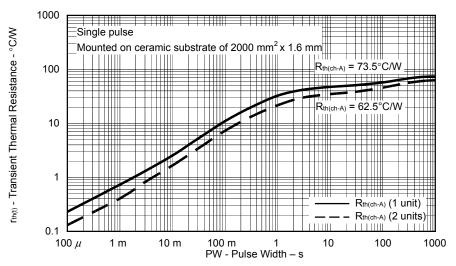






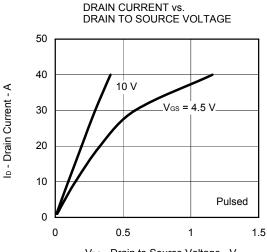


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



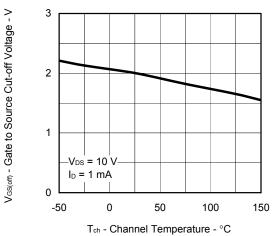
Data Sheet G18592EJ1V0DS

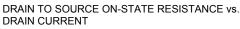


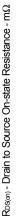


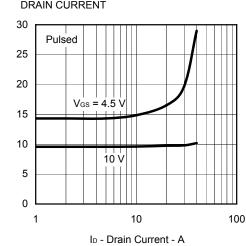
V_{DS} - Drain to Source Voltage - V



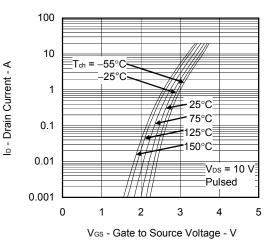




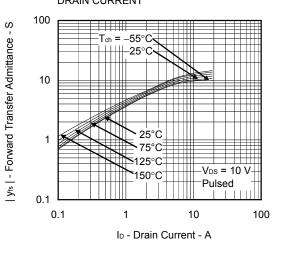




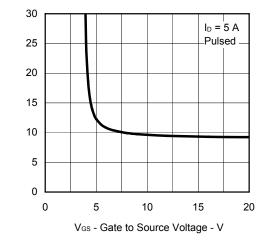




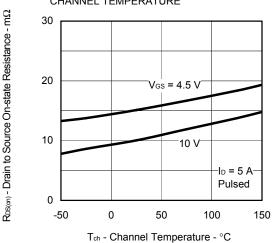
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

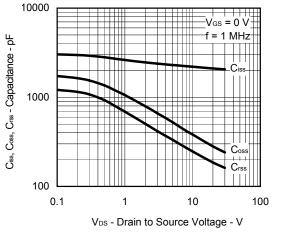


 $R_{DS(cn)}$ - Drain to Source On-state Resistance - $m\Omega$

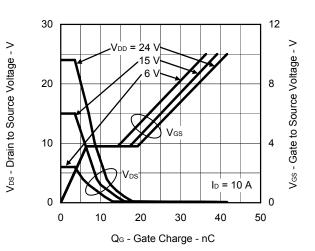


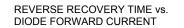
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

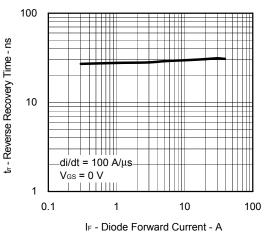
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



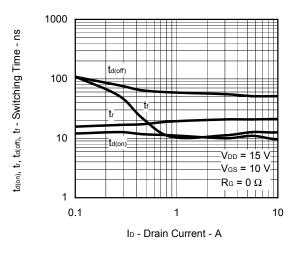
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



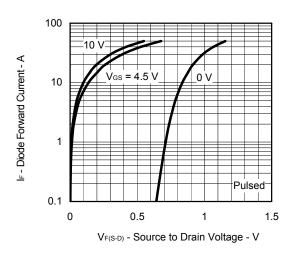




SWITCHING CHARACTERISTICS

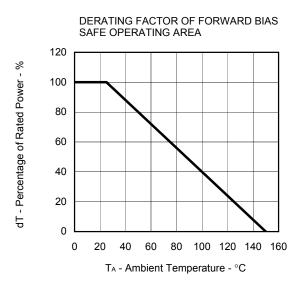


SOURCE TO DRAIN DIODE FORWARD VOLTAGE

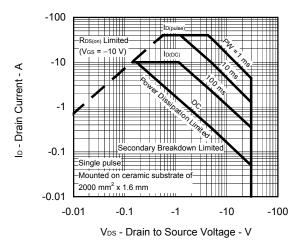


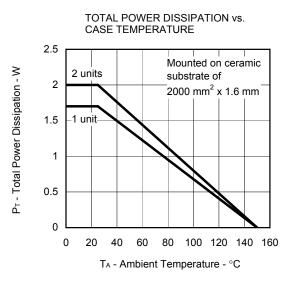
Data Sheet G18592EJ1V0DS

(2) P-channel

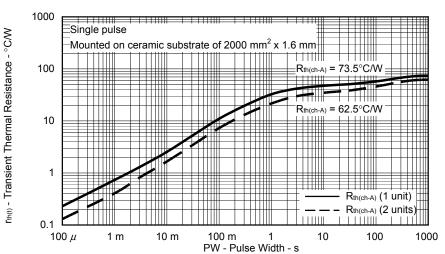




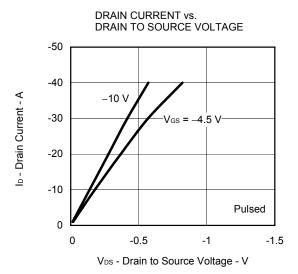




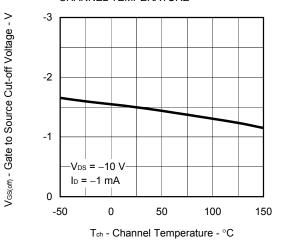
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

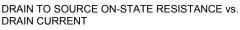


Data Sheet G18592EJ1V0DS

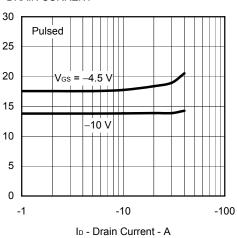




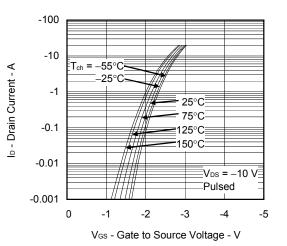




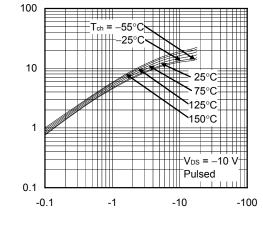




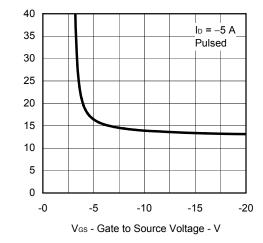
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



ID - Drain Current - A

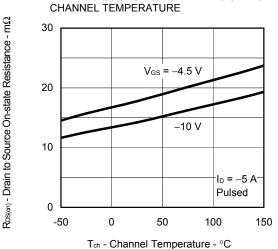


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

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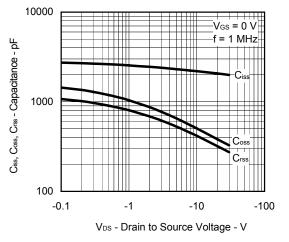
| yts | - Forward Transfer Admittance -

 $R_{DS(cn)}$ - Drain to Source On-state Resistance - $m\Omega$

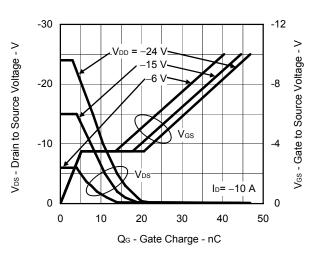


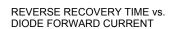
DRAIN TO SOURCE ON-STATE RESISTANCE vs. C/

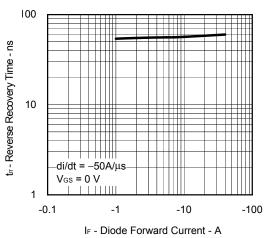
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



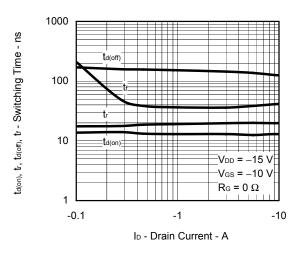
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



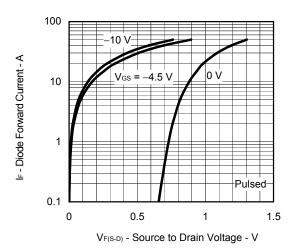








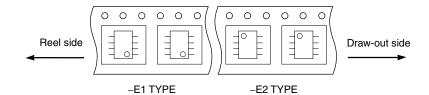
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



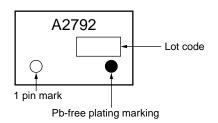
Data Sheet G18592EJ1V0DS

TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

The μ PA2792GR should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	eflow Maximum temperature (Package's surface temperature): 260°C or below	
	Time at maximum temperature: 10 seconds or less	
	Time of temperature higher than 220°C: 60 seconds or less	
	Preheating time at 160 to 180°C: 60 to 120 seconds	
	Maximum number of reflow processes: 3 times	
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less	
Partial heating	Maximum temperature (Pin temperature): 350°C or below	P350
	Time (per side of the device): 3 seconds or less	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less	

Caution Do not use different soldering methods together (except for partial heating).

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